

**Search Notes**

Application/Control No.

10/726,852

Examiner

Yuzhen Ge

Applicant(s)/Patent under  
Reexamination

YANO ET AL.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT, US-PUPUB, EPO, JPO, DERWENT, IBM_TDB, USOCR) - See search history printout	8/1/2007	YG
IEEE Xplore - See search session history printout	8/1/2007	YG
Search 382/232 with text limitation	8/1/2007	YG
Updated the above search	1/15/2008	YG